

N-Channel Enhancement-Mode MOS Transistors, Zener Gate Protected

calogic
CORPORATION

VN0610L / VN10KE / VN10KM / VN10KT

FEATURES

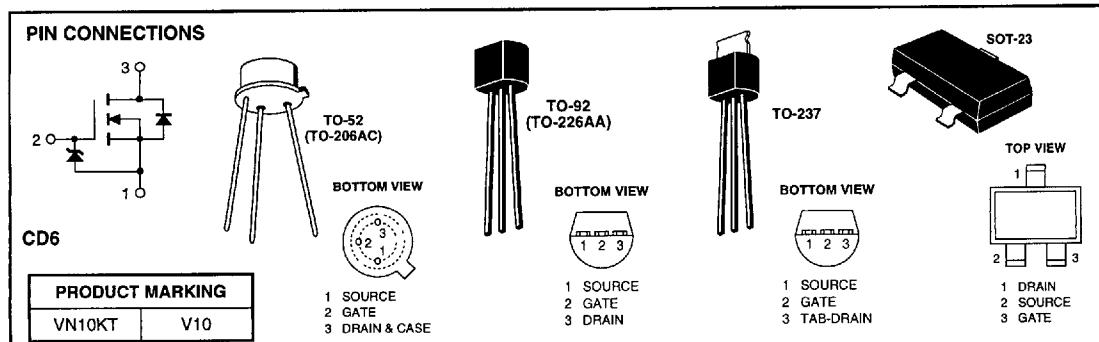
- Available in Surface Mount SOT-23
- Zener protected
- Low $r_{ds(on)} < 5\Omega$
- 60V Bv

APPLICATIONS

- Switching
- Amplification

ORDERING INFORMATION

Part	Package	Temperature Range
VN0610L	Plastic TO-92	-55°C to +150°C
VN10KE	Hermetic TO-52	-55°C to +150°C
VN10KM	Plastic TO-237	-55°C to +150°C
VN10KT	Surface Mount SOT-23	-55°C to +150°C
XVN10KM	Sorted chips in carriers	-55°C to +150°C



ABSOLUTE MAXIMUM RATINGS ($T_A = 25^\circ C$ unless otherwise noted)

SYMBOL	PARAMETERS/TEST CONDITIONS	LIMITS				UNITS
		VN0610L	VN10KE	VN10KM	VN10KT	
V_{DS}	Drain-Source Voltage	60	60	60	60	V
V_{GS}	Gate-Source Voltage ²	15/-0.3	15/-0.3	15/-0.3	15/-0.3	
I_D	Continuous Drain Current	0.27	0.17	0.31	0.27	A
		0.17	0.11	0.20	0.17	
I_{DM}	Pulsed Drain Current ¹	1	1	1	1	
P_D	Power Dissipation	0.8	1.5	1	0.8	W
		0.32	0.12	0.4	0.32	
T_J, T_{STG}	Operating Junction & Storage Temperature Range	-55 to 150				°C
T_L	Lead Temperature (1/16" from case for 10 sec.)	300				

THERMAL RESISTANCE RATINGS

SYMBOL	THERMAL RESISTANCE	LIMITS			UNITS
		VN0610L	VN10KE	VN10KM	
R_{thJA}	Junction-to-Ambient	156	400	125	K/W

¹Pulse width limited by maximum junction temperature.

²Features internal gate-source Zener diode.

SPECIFICATIONS ^a		LIMITS					
SYMBOL	PARAMETER	TYP ^b	MIN	MAX	UNIT	TEST CONDITIONS	
STATIC							
$V_{(BR)DSS}$	Drain-Source Breakdown Voltage	120	60		V	$I_D = 100\mu A, V_{GS} = 0V$	
$V_{GS(th)}$	Gate-Threshold Voltage	1.4	0.8	2.5		$V_{DS} = V_{GS}, I_D = 1mA$	
I_{GS}	Gate-Body Leakage	1		100	nA	$V_{GS} = 15V, V_{DS} = 0V$	
I_{DSS}	Zero Gate Voltage Drain Current	0.7		10	μA	$V_{DS} = 48V, V_{GS} = 0V$	$T_J = 125^\circ C$
		3		500			
$I_{D(ON)}$	On-State Drain Current	1000	750		mA	$V_{DS} = 10V, V_{GS} = 10V$	
$r_{DS(ON)}$	Drain-Source On-Resistance ^c	4		7.5	Ω	$V_{GS} = 5V, I_D = 0.2A$	
		3		5		$V_{GS} = 10V, I_D = 0.5A$	
		5.6		9			$T_J = 125^\circ C$
g_{FS}	Forward Transconductance ^c	300	100		mS	$V_{DS} = 10V, I_D = 0.5A$	
g_{OS}	Common Source Output Conductance ^c	200			μS	$V_{DS} = 7.5V, I_D = 50mA$	
DYNAMIC							
C_{iss}	Input Capacitance	38		60	pF	$V_{DS} = 25V, V_{GS} = 0V, f = 1MHz$	
C_{oss}	Output Capacitance	16		25			
C_{rss}	Reverse Transfer Capacitance	2		5			
SWITCHING							
t_{ON}	Turn-On Time	7		10	ns	$V_{DD} = 15V, R_L = 23\Omega, I_D = 0.6A$ $V_{GEN} = 10V, R_G = 25\Omega$	
t_{OFF}	Turn-Off Time	9		10		(Switching time is essentially independent of operating temperature)	

Notes:

- a. $T_A = 25^\circ C$ unless otherwise noted.
- b. For design aid only, not subject to production testing.
- c. Pulse test; $PW = \leq 300\mu S$, duty cycle $\leq 2\%$

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